



FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use Several Sheets if Necessary)	ATTORNEY DOCKET NO.: LDQ-1190-CIP-2	APPLICATION NO.: 09/580,026
	APPLICANT: S. Dershem et al.	
	FILING DATE: August 29, 2002	GROUP: 1712

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIAL	PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SMC	4,323,662	04/1982	Oba, et al.	525	281	
A	4,369,302	01/1983	Ikeguchi, et al.	528	73	
	4,564,663	01/1986	Martin, et al.	526	262	
	4,740,343	04/1988	Gaku, et al.	264	225	
	4,853,449	09/1989	Domeier	526	259	
	4,886,842	12/1989	Drain, et al.	522	103	
	5,358,992	10/1994	Dershem, et al.	524	439	
	5,359,020	10/1994	Bunner, et al.	526	262	
	5,364,700	11/1994	Domeier	428	394	
	5,380,768	01/1995	Cranston, et al.	521	167	
	5,405,686	04/1995	Portelli, et al.	428	229	
	5,442,039	08/1995	Hefner, Jr., et al.	528	422	
	5,447,988	09/1995	Dershem, et al.	524	780	
	5,470,920	11/1995	Camberlin, et al.	525	421	
	5,475,048	12/1995	Jamison, et al.	524	439	
	5,483,101	01/1996	Shimoto, et al.	257	701	
	5,527,592	06/1996	Afzali-Ardakani, et al	428	209	
	5,536,970	07/1996	Higashi, et al.	257	676	
	5,599,611	02/1997	Afzali-Ardakani, et al	442	180	

DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
SMC	0 318 162 A2	10/1988	EPC	C07D	207/452

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)					
SMC			Romenesko, B., Ball Grid Array & Flip Chip Technologies: Their Histories & Prospects, Vol. 19, No. 1, The International Journal of Microcircuits & Electronic Packaging, (1996)		
			Smith, Mark A., et al, "Bismaleimide/Vinyl Ether Matrix Copolymers, pp. 337-338 Roderick, William, "Deydration of N-(p-Chloropheynl) phthalamic Acid by Acetic and Trifluoroacetic Anhydrides", Vol. 29, pp.745-747 (1964)		
A			Cotter, Robert, J., et al, "The Synthesis of N-Substituted Isomaleimides", pp. 10-15, (1960)		

EXAMINER: SMC	DATE CONSIDERED: 12/5/03
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.	